Notice of References Cited Application/Control No. 10/531,817 Examiner KEZHEN SHEN Applicant(s)/Patent Under Reexamination FUKUSHIMA ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,485,439 A	01-1996	Hamasaka et al.	369/47.36
*	В	US-6,430,120 B1	08-2002	Chritz et al.	369/30.12
*	O	US-2002/0126993 A1	09-2002	Sakuramoto et al.	386/77
*	D	US-2002/0126601 A1	09-2002	Liew, Bee-Bee	369/47.51
*	Е	US-6,526,146 B1	02-2003	Hashimoto et al.	380/201
*	F	US-2004/0160873 A1	08-2004	Pereira, David M.	369/047.53
*	G	US-6,799,242 B1	09-2004	Tsuda et al.	711/106
*	Ι	US-6,853,609 B2	02-2005	Kusumoto et al.	369/44.29
	_	US-			
	7	US-			
	K	US-			
	┙	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Ø					
	R					
	Ø					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	<	
	W	
	х	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.